

Product data sheet

1. General description

Hyperfast power diode in a SOD113 (2-lead TO-220F) plastic package.

2. Features and benefits

- Fast switching
- Isolated plastic package
- Low leakage current
- Low reverse recovery current
- Low thermal resistance
- Reduces switching losses in associated MOSFET

3. Applications

- Continuous Current Mode (CCM) Power Factor Correction (PFC)
- Half-bridge/full-bridge switched-mode power supplies

4. Quick reference data

Table	1.	Quick	reference	data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _R	reverse voltage	DC	-	-	600	V
I _{F(AV)}	average forward current	δ = 0.5; T _h ≤ 75 °C; square-wave pulse; <u>Fig. 1</u> ; <u>Fig. 2</u> ; <u>Fig. 3</u>	-	-	8	A
I _{FRM}	repetitive peak forward current	δ = 0.5; t _p = 25 μs; T _h ≤ 75 °C; square-wave pulse	-	-	16	A
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; Fig. 4	-	-	91	A
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse	-	-	100	A
Static chara	acteristics					
V _F	forward voltage	I _F = 8 A; T _j = 25 °C; <u>Fig. 6</u>	-	-	3.4	V
		I _F = 8 A; T _j = 125 °C; <u>Fig. 6</u>	-	1.5	1.9	V
		I _F = 8 A; T _j = 150 °C	-	1.4	-	V
Dynamic ch	naracteristics		· · ·			
t _{rr}	reverse recovery time	$ I_F = 1 \text{ A}; V_R = 30 \text{ V}; \text{d}_F/\text{d}t = 200 \text{A}/\mu\text{s}; \\ \text{T}_j = 25 ^\circ\text{C}; \frac{\text{Fig. 7}}{2} $	-	12	18	ns
		I _F = 8 A; V _R = 400 V; dI _F /dt = 500 A/µs; T _i = 25 °C; <u>Fig. 7</u>	-	19	-	ns

5. Pinning information

Table 2. F	Pinning inf	formation		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	К	cathode	mb	К — К — А
2	А	anode		001aaa020
mb	n.c.	mounting base; isolated	TO-220F (SOD113)	

6. Ordering information

Table 3. Ordering information						
Type number	Package					
	Name	Description	Version			
BYC8X-600P	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 2-lead TO-220 "full pack"	SOD113			

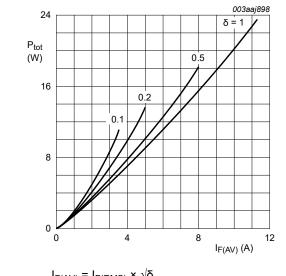
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7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	N	Vin	Max	Unit
V _{RRM}	repetitive peak reverse voltage		-		600	V
V _{RWM}	crest working reverse voltage		-		600	V
V _R	reverse voltage	DC	-		600	V
I _{F(AV)}	average forward current	δ = 0.5; T _h ≤ 75 °C; square-wave pulse; Fig. 1; Fig. 2; Fig. 3	-		8	A
I _{FRM}	repetitive peak forward current	δ = 0.5; t_p = 25 µs; T_h \leq 75 °C; square-wave pulse	-		16	A
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; Fig. 4	-		91	A
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse	-		100	A
T _{stg}	storage temperature		-(65	175	°C
Tj	junction temperature		-		175	°C



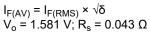
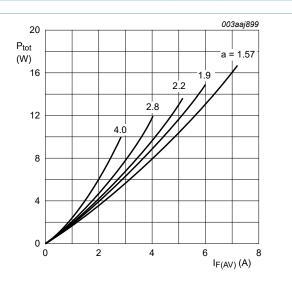


Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values



a = form factor = I_{F(RMS)} / I_{F(AV)} V_o = 1.581V; R_s = 0.043 Ω

Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values

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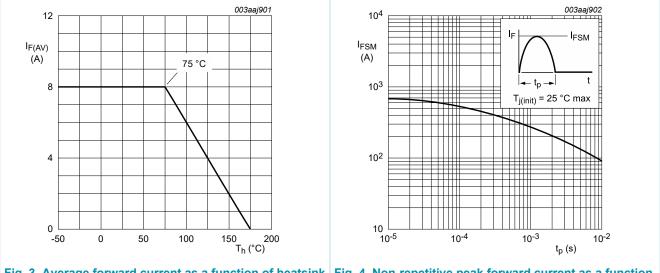


Fig. 3. Average forward current as a function of heatsink
temperature; maximum valuesFig. 4. Non-repetitive peak forward current as a function
of pulse width; sinusoidal waveform; maximum values

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8. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-h)}	thermal resistance	without heatsink compound	-	-	7.2	K/W
	from junction to heatsink	with heatsink compound; Fig. 5	-	-	5.5	K/W
R _{th(j-a)}	thermal resistance from junction to ambient free air		-	60	-	K/W

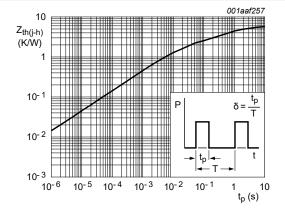


Fig. 5. Transient thermal impedance from junction to heatsink as a function of pulse width

9. Isolation characteristics

Table 6. Isolati	able 6. Isolation characteristics						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{isol(RMS)}	RMS isolation voltage	50 Hz \leq f \leq 60 Hz; RH \leq 65 %; from all pins to external heatsink; sinusoidal waveform; clean and dust free		-	-	2500	V
C _{isol}	isolation capacitance	from cathode to external heatsink		-	10	-	pF

Table 6. Isolation characteristic



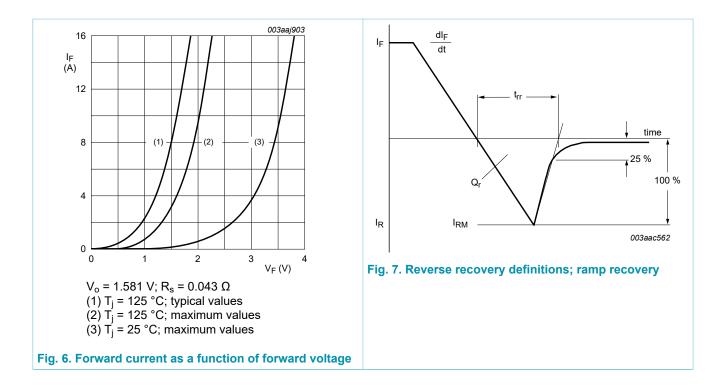
10. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
V _F	forward voltage	I _F = 8 A; T _j = 25 °C; <u>Fig. 6</u>	-	-	3.4	V
		I _F = 8 A; T _j = 125 °C; <u>Fig. 6</u>	-	1.5	1.9	V
		I _F = 8 A; T _j = 150 °C	-	1.4	-	V
I _R	reverse current	V _R = 600 V; T _j = 25 °C	-	-	20	μA
		V _R = 600 V; T _j = 125 °C	-	-	200	μA
Dynamic ch	naracteristics					
t _{rr}	reverse recovery time	$ I_F = 1 \text{ A}; \text{ V}_R = 30 \text{ V}; \text{ d}I_F/\text{d}t = 200 \text{ A}/\mu\text{s}; \\ T_j = 25 \text{ °C}; \text{ Fig. 7} $	-	12	18	ns
		I_F = 8 A; V _R = 400 V; dI _F /dt = 500 A/µs; T _j = 25 °C; Fig. 7	-	19	-	ns
I _{RM}	peak reverse recovery current	I_F = 8 A; V _R = 200 V; dI _F /dt = 200 A/µs; T _j = 25 °C; Fig. 7	-	-	2.2	A
		I_F = 8 A; V _R = 200 V; dI _F /dt = 200 A/µs; T _j = 125 °C; Fig. 7	-	-	6	A
Qr	recovered charge	I_F = 8 A; V _R = 200 V; dI _F /dt = 200 A/µs; T _j = 25 °C; <u>Fig. 7</u>	-	17	-	nC
		I _F = 8 A; V _R = 200 V; dI _F /dt = 200 A/μs; T _i = 125 °C; <u>Fig. 7</u>	-	90	-	nC

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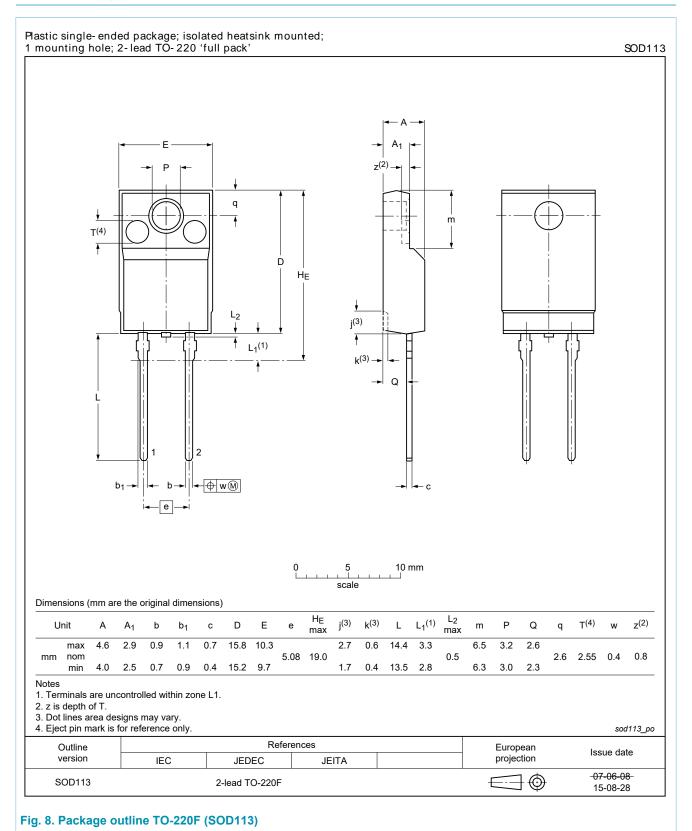
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11. Package outline



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12. Legal information

Data sheet status

Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

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